Notice of References Cited Application/Control No. 10/643,926 Examiner Brian R. Gordon Applicant(s)/Patent Under Reexamination MEYER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0072122	06-2002	Copeland et al.	436/46
*	В	US-2002/0012611	01-2002	STYLLI et al.	422/65
*	С	US-6,848,633	02-2005	Ryser, Daniel	239/424
*	D	US-6,551,833	04-2003	Lehtinen et al.	436/48
*	Ε	US-6,422,248	07-2002	Furst et al.	134/22.11
*	F	US-6,269,846	08-2001	Overbeck et al.	141/1
*	G	US-5,807,523	09-1998	Watts et al.	422/64
*	Н	US-5,629,201	05-1997	Nugteren et al.	435/283.1
*	ı	US-5,085,832	02-1992	Shaw et al.	422/63
*	J	US-4,815,978	03-1989	Mazza et al.	435/4
*	К	US-4,347,750	09-1982	Tersteeg et al.	73/864.31
*	L	US-2006/0051247	03-2006	Micklash et al.	422/100
*	М	US-4,871,682	10-1989	Mazza, John C.	436/179

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		•			
	Р					
	Q					
	R				-	
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.